

ELEC 315:

2 - Crystal structure and growth

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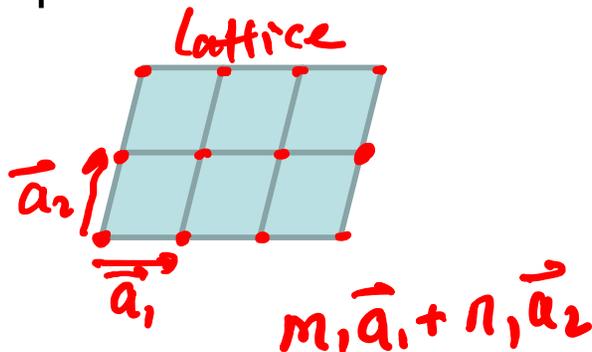
Outline

- Crystal structure in solids
- Crystalline, polycrystalline, amorphous materials
- Crystal growth
- Conductivity: Metals, semiconductors, and dielectrics

Crystal Structure

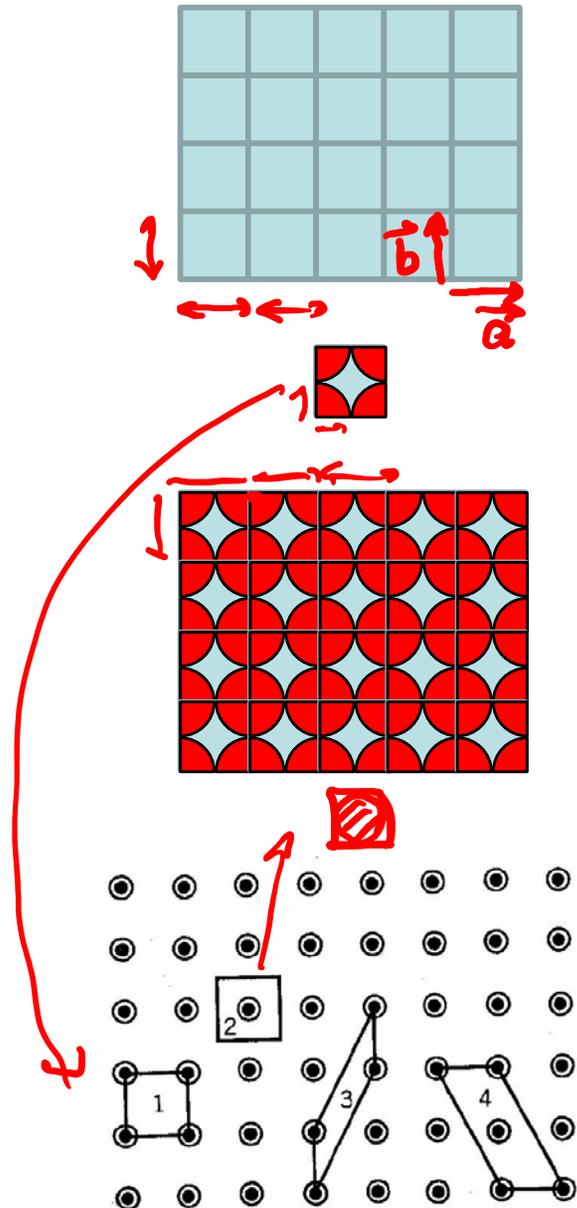
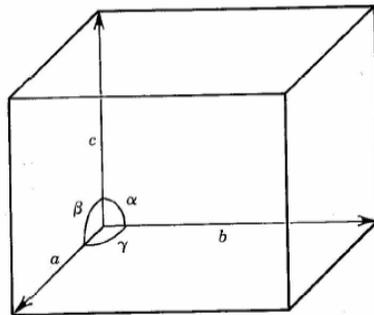
quartz

- Solid materials with ordered and periodic structure are called **crystals**. Examples: **diamond (C), NaCl, Si, Sugar, liquid crystal (LC)**
- The crystal appears exactly the same at one point as it does at the other equivalent points, once we know the periodicity. Crystals have a high degree of **symmetry**.
- The reason behind this well-ordered crystalline structure is the bonds between atoms and molecules.
- Examples of the type of bonds:
 - Covalent bond: Si
 - Ionic bond: NaCl
- The grid for repeating pattern in a crystal is called **lattice** and what is repeated is called **unit cell**.



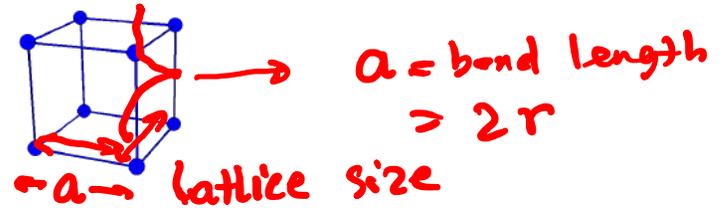
Unit cell and basis vectors

- A *unit cell* is a small volume that can be used to make the entire crystal when it is regularly repeated over the *lattice*.
- If we translate a unit cell by integral multiples of *basis vectors (lattice)* we reach another identical unit cell. The basis vectors link the unit cell to the lattice.
- A *primitive unit cell* is the smallest unit cell that can be used to form a specific crystal structure.



Different unit cells

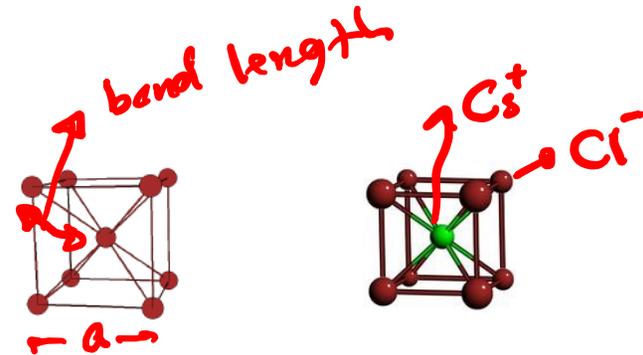
- *Simple cubic (SC)* lattice: The unit cell is a cube and there is one atom at each corner of the unit cell. The side of the cube a is the period of the lattice.



$$8 \text{ atoms} \times \frac{1}{8} (\text{corner}) = 1 \text{ atoms}$$

$$\frac{1 \text{ atom}}{a^3} \quad (\text{cm}^{-3})$$

- *Body-centred cubic (BCC)* lattice has an additional atom at the centre of the cube. (Na, Fe, Cr, ..., CsCl, ...)



$$1 (\text{centre}) + 8 \times \frac{1}{8} = 2 \text{ atoms}$$

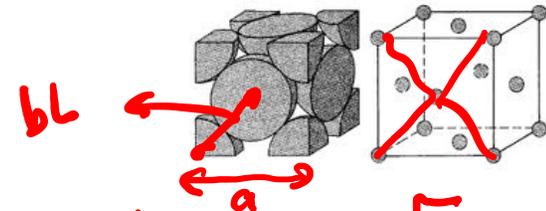
$$\text{bond length} = \frac{\sqrt{3} a}{2}$$

Different unit cells

- *Face-centred cubic (FCC)* lattice has atoms at the eight corners and centered on the six faces. (Cu, Al, Ni, Ag, ...)

$$8 \times \frac{1}{8} + 6 \times \frac{1}{2} = 4 \text{ atoms}$$

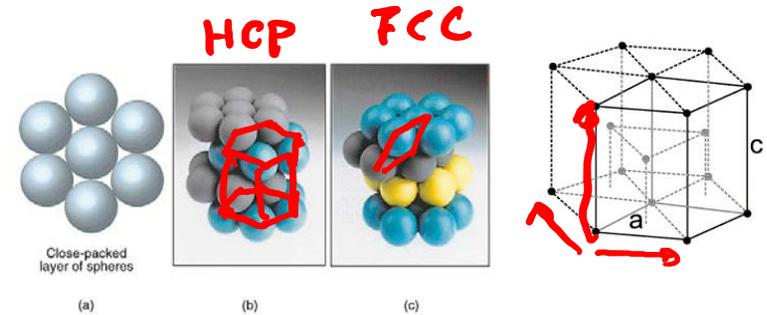
corner face



$$\text{bond length} = \frac{\sqrt{2}}{2} a$$

- *Hexagonal closed-pack (HCP)*: This structure provides closest layered packing for spheres. It is like (ABA in the figure) very similar to FCC (ABC in the figure).

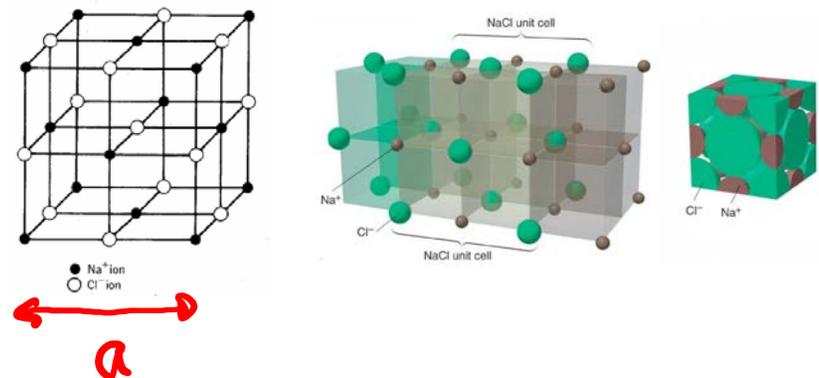
$$\frac{1}{6} \times 12 + 2 \times \frac{1}{2} + 3 = 6 \text{ atoms}$$



- NaCl crystal

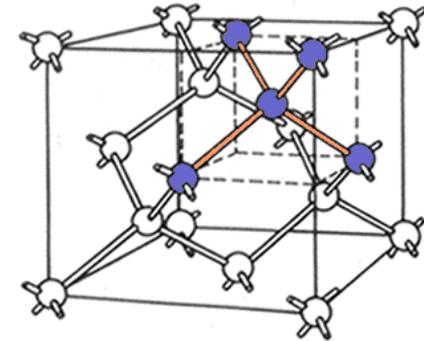
$$\text{Na}^+ : 8 \times \frac{1}{8} + 6 \times \frac{1}{2} = 4 \text{ ions}$$

$$\text{Cl}^- : 1 + 12 \times \frac{1}{4} = 4 \text{ atoms}$$



Crystal structure of Silicon

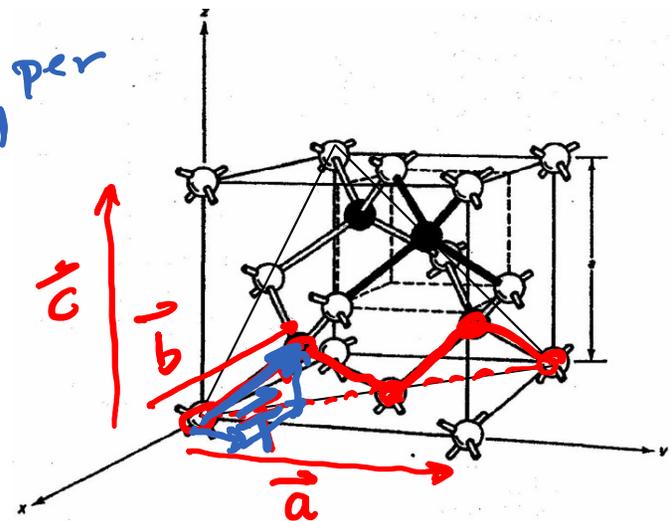
- *Diamond* unit cell: Semiconductors such as silicon and germanium have diamond lattice. In diamond lattice, each atom is symmetrically bonded to four other atoms in a tetrahedral configuration.
- The unit cell for a diamond lattice is made of a **fcc unit** cell with an extra atom placed at $a/4+b/4+c/4$ from each of the fcc atoms.



$$\vec{T} = \frac{\vec{a}}{4} + \frac{\vec{b}}{4} + \frac{\vec{c}}{4}$$

$$\text{bond length} = |\vec{T}| = \frac{\sqrt{3}}{4} a$$

8 atoms per unit cell

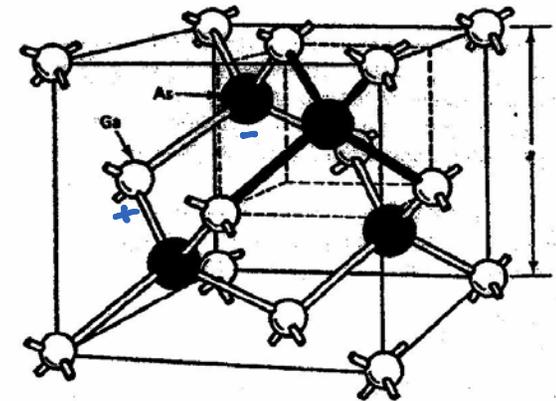


See Pulfrey & Tarr 2.2

Zincblende Lattice

$ZnS, ZnSe$

- Many compound semiconductors (such as GaAs, InP, GaP, ZnS...) have a crystalline structure very similar to a diamond lattice, however, there are two types of atoms in the unit cell.
- These semiconductors have a *zincblende* lattice.



zincblende

GaAs steichentry

III-V semiconductor

II-VI semiconductor

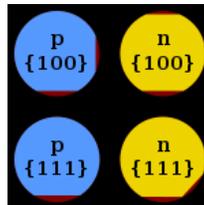
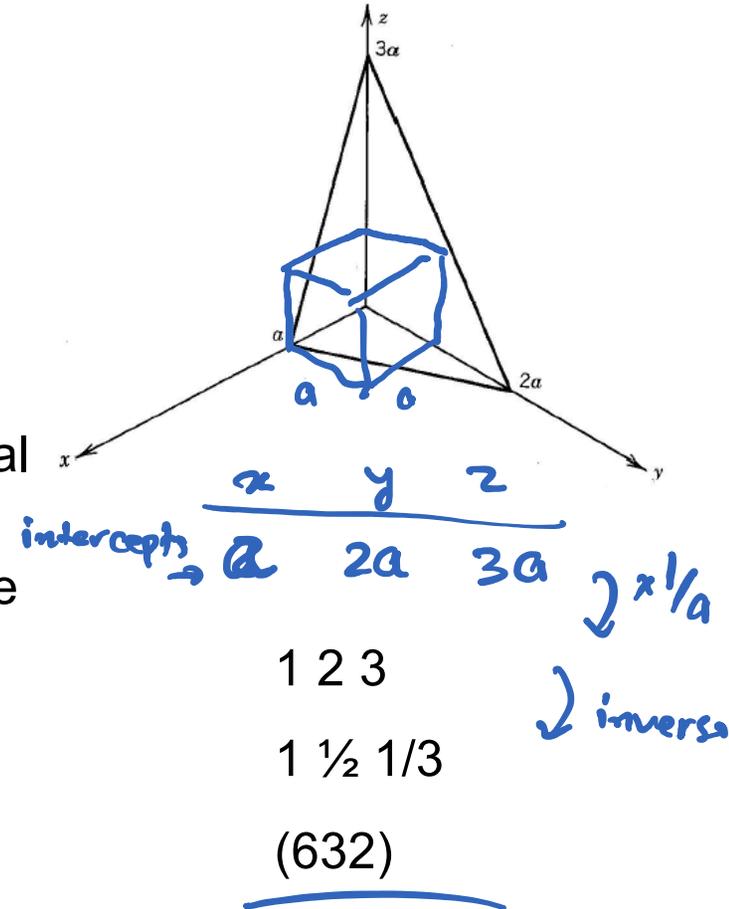
4 Ga atoms

4 As atoms

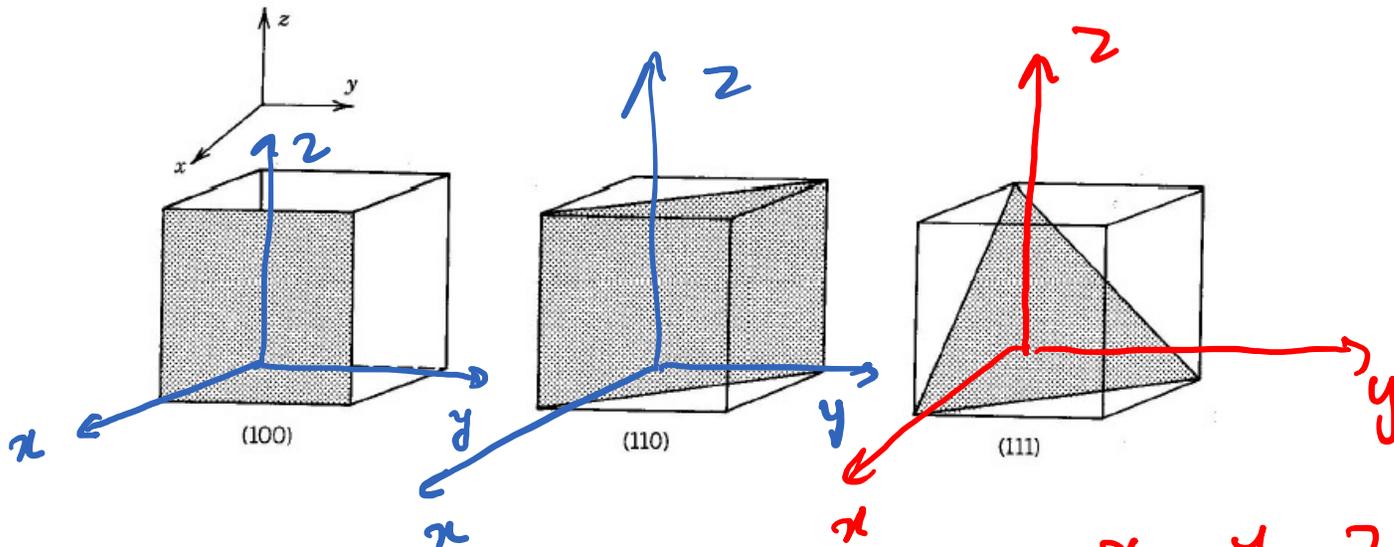
See Pulfrey & Tarr 2.2

Crystal planes

- To be able to refer to different crystal planes and directions in the crystal we use *Miller indices*.
- Three integers $(h\ k\ l)$ is used to describe a plane in a crystal.
- To find these indices:
 - Find the intercept of the planes with the crystal axes as integral multiples of basis vectors.
 - Take the reciprocal of the integers and reduce them to smallest set of integers.
 - If intercept is negative, the integer is shown with a bar.



Example



x	y	z
a	∞	∞
l	∞	∞
l	0	0

(100)

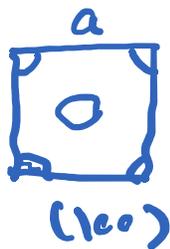
x	y	z
a	a	∞
l	l	∞
l	l	0

(110)

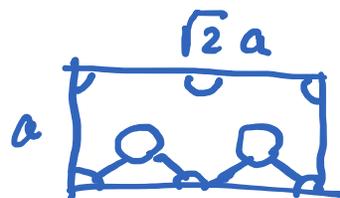
x	y	z
a	a	a
l	l	l

(111)

surface density
 $2/a^2$



face planes
(010)
(001)

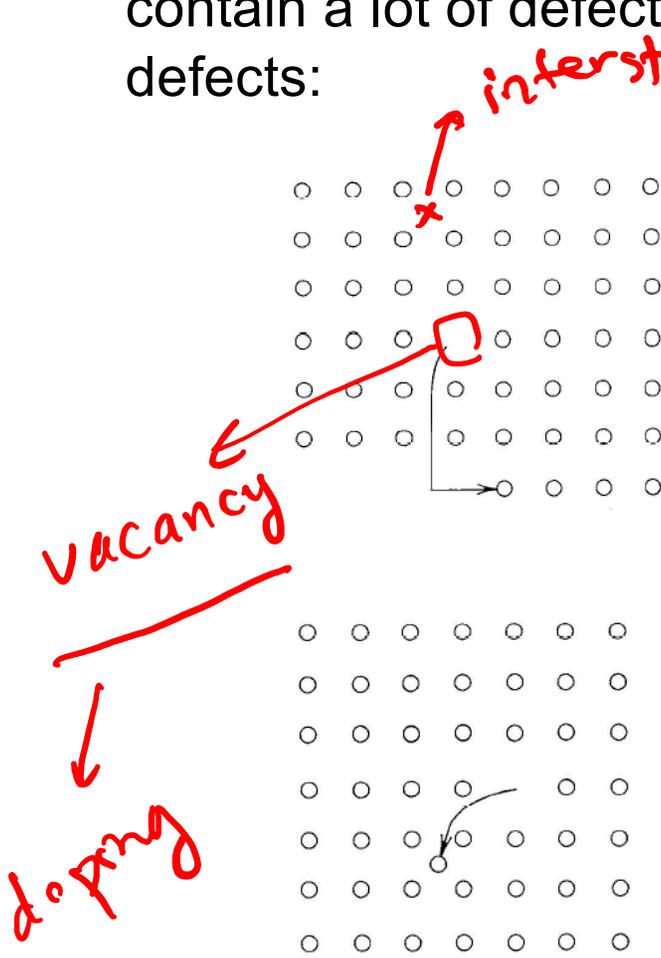


Crystal defects

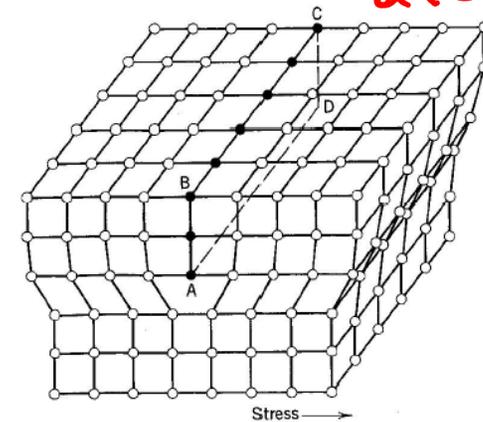
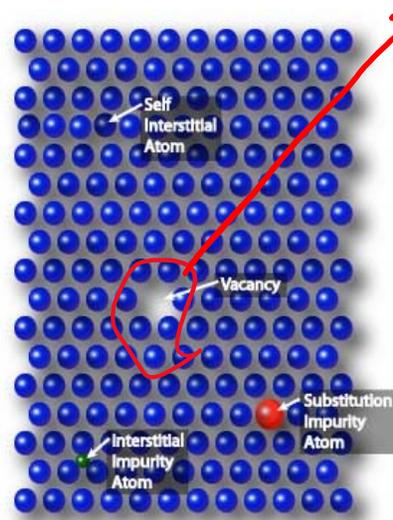
$$N_{Si} = 5 \times 10^{22} \text{ cm}^{-3}$$

$$N_{\text{defects}} \sim 10^{10} \text{ cm}^{-3}$$

- In reality, the crystals are not perfect and contain a lot of defects. Examples of these defects:

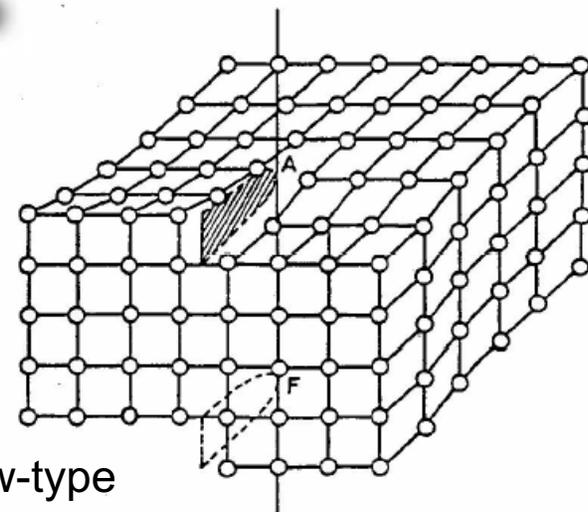


Point defects
(vacancy, interstitial)



dislocation

dopants alloying

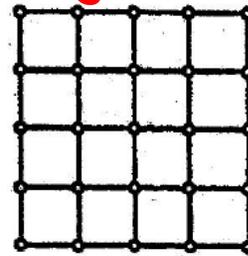


Screw-type dislocation

Crystallinity

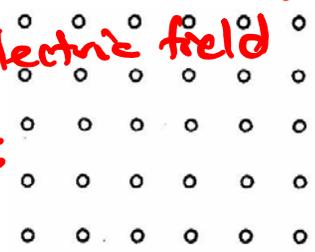
- The crystalline structure of a solid determines its properties.
- Crystalline

mobility



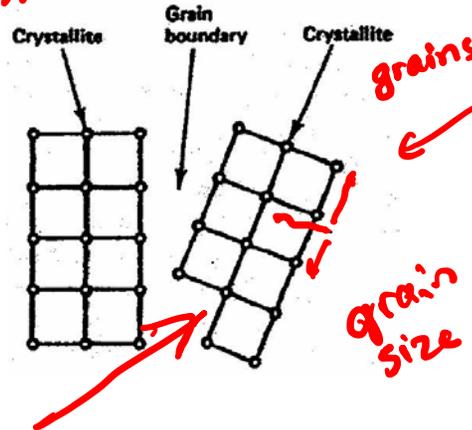
$\sigma = q \mu_n n$
 ← mobility →
 electron charge →
 → drift velocity
 $\mu = \frac{v_d}{E}$
 → electric field

$\mu_n = 1350 \frac{cm^2}{Vs}$

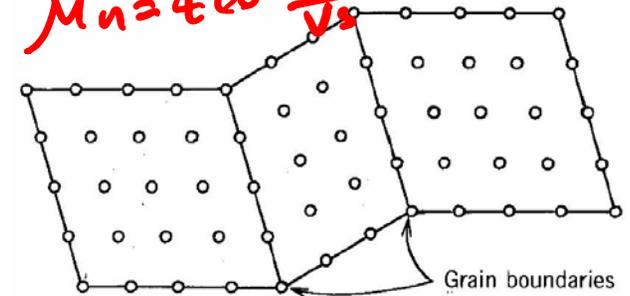


- Polycrystalline
- (microcrystalline)
- (nanocrystalline)

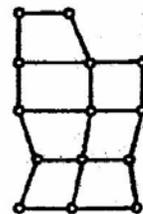
1 μm - 1 nm



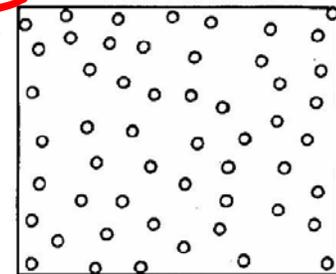
$\mu_n = 400 \frac{cm^2}{Vs}$



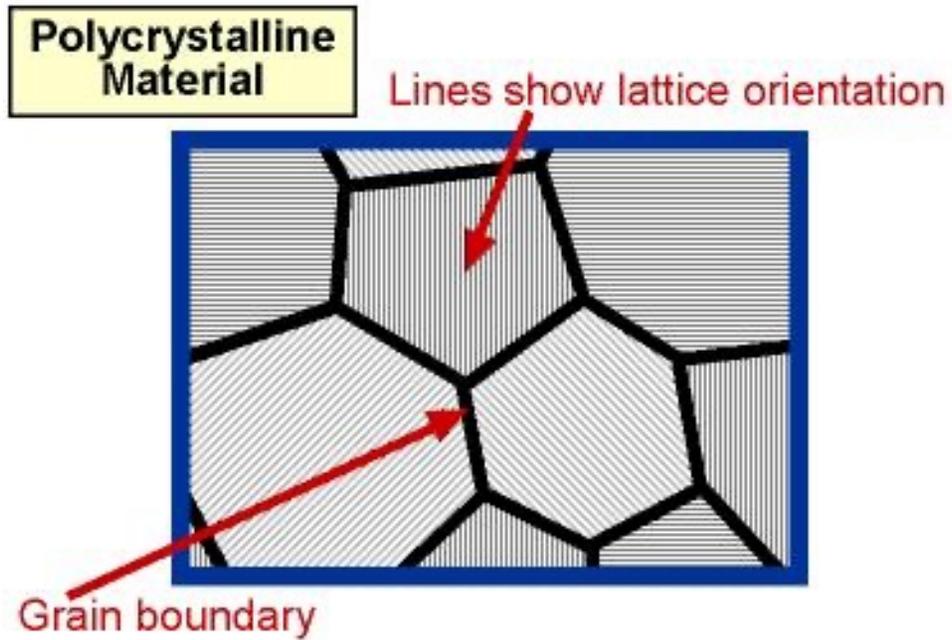
- Amorphous
disordered
glass



$\mu_n = 1 \frac{cm^2}{Vs}$



Polycrystalline Materials



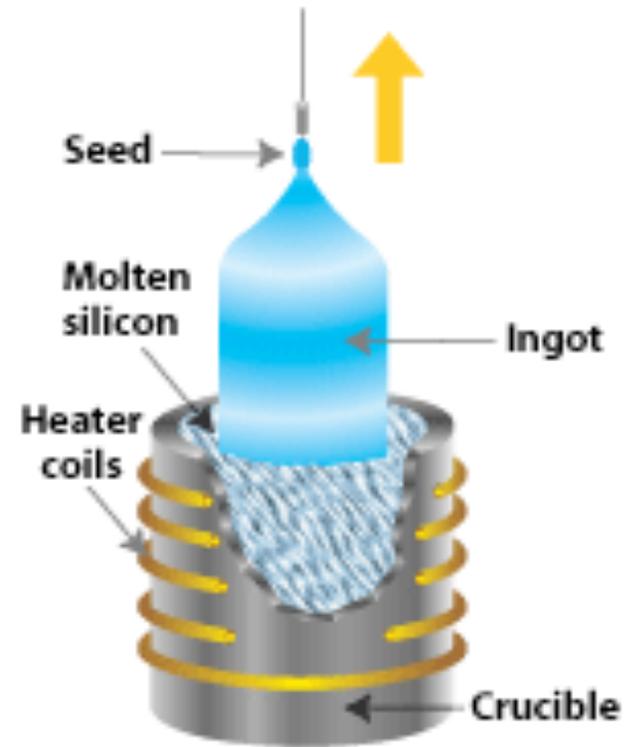
http://www.eng.auburn.edu/~wfgale/intro_metals/graphics/fig8_polycrys.jpg



<http://www.jwave.vt.edu/crcd/farkas/lectures/dislocations/fig9.gif>

Amorphous

Single Crystal Growth



http://www.eere.energy.gov/solar/images/illust_czoch.gif

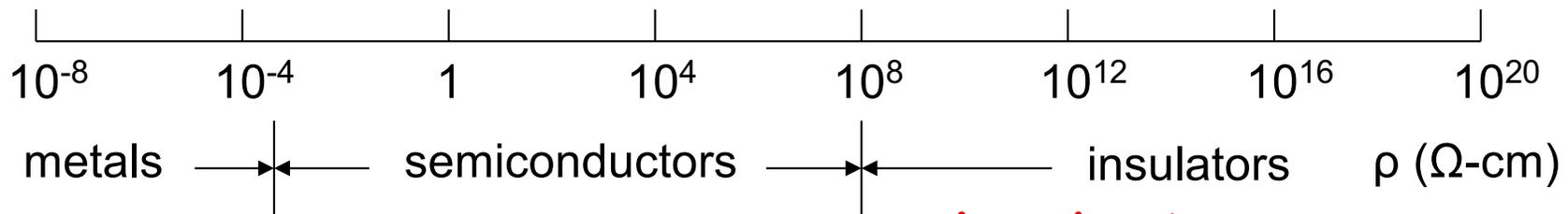
<http://www.shef.ac.uk/~ch1mlt/teaching/chm337/si-crystal.jpg>

Silicon Single Crystal
Up to 300 mm diameter

See Pulfrey & Tarr 2.2.2

Conductivity and Resistivity

- Conductivity and resistivity are important parameters that can be measured and define the type of the material.
- $\sigma = 1/\rho$ ($\Omega^{-1}\text{cm}^{-1}$ or S/cm) $\sigma = q \mu n n$

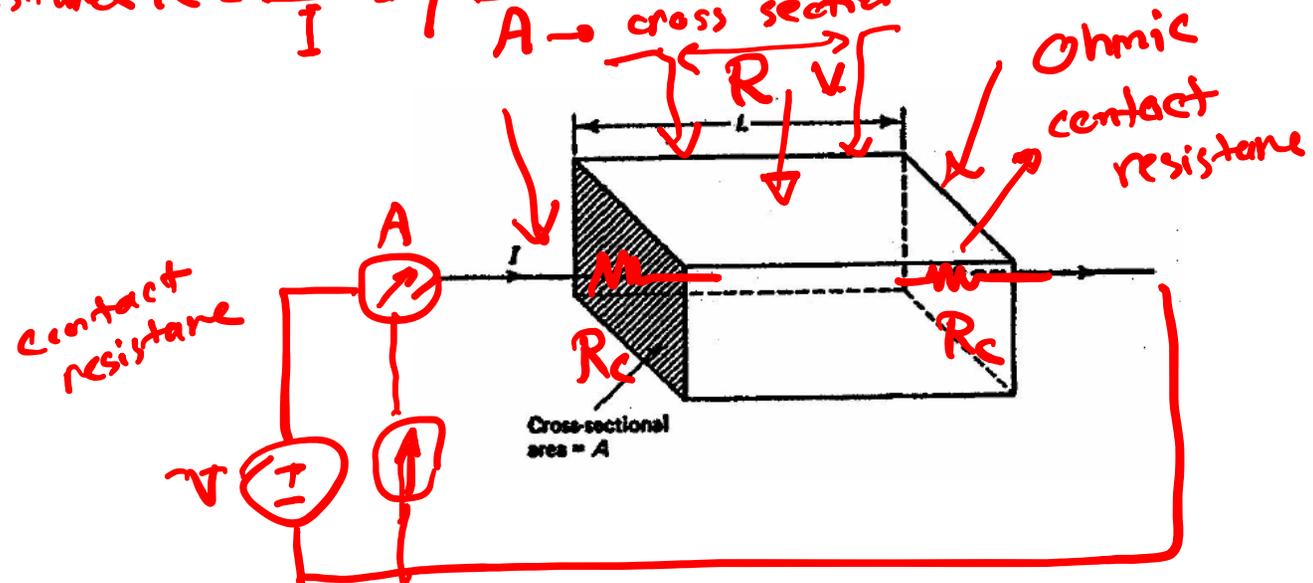


resistance $R = \frac{V}{I} = \rho \frac{L}{A}$

L → length
 A → cross section

$$\sigma = \frac{LI}{AV} = \frac{L}{AR}$$

$R_M = R + 2R_c$

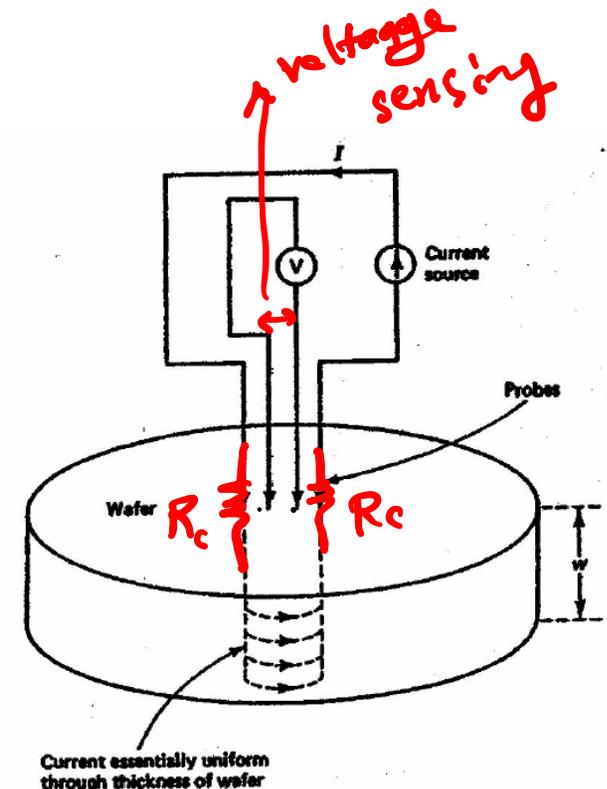


Four point probe

- To find conductivity of a (silicon) wafer, an important experiment is four point probe experiment.
- Four probes are used. A current I is passed through the outer probes and the voltage drop V over the inner probes are measured.
- For this experiment, the conductivity is give by

$$\sigma = \frac{I \ln 2}{V \pi w}$$

w → width of wafer



Next lecture

- Basic quantum physics of semiconductors
- Reading for next week: Pulfrey and Tarr, Chapter 2: 2.1, 2.2
- Also read semiconductor quantum mechanics <http://ece-www.colorado.edu/~bart/book/contents.htm> 1.2.1-1.2.2 & 1.2.5-1.2.5.2.